

_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/080,067	WARIISHI ET AL.	
	Examiner	Art Unit	
	Robert Hodge	1746	

	SEARCHED					
Class	Subclass	Date		Examiner		
429	313,317	1-4-0	15	Rull		
	306, 129					
	188,323					
	345, 312					
	213,314					
	218,1,303					
	307,308					
	144, 33					
252	62.2	-				
	299.61					
	512					
136	263					
29	623.5					
525	331.9	V				

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
429	313 & 317	1/4/2005				
429	188	1/4/2005				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted Jonathan Crepeau Re: Prior Art and Search Strategy	12/30/04	Rwil		
Consulted Joseph Perrin Re: Basic Polymer Structure	1/3/2005	Ruil		
Consulted Jonathan Crepeau Re: Allowable Subject Matter	1/3/2005	Rwil		
Consulted Bruce Bell Re: Allowable Subject Matter	1/4/2005	Ruff		
Inventor Search See attached East Search History	12/30/2004	Ruit		
See Attached East Search History	1/4/2005	RwH		
See Attached STIC Search Report	12/31/2004	RuH		
Plus Search	1-3-05	RVH		